Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/835,643	AHN ET AL.
Examiner	Art Unit
Leonardo Andújar	2826

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPTO database (FULL) JPO, EPO, DERWENT, IBM_TDB (ABS) IEEEXplore KEY: coplanar waveguide, trench waveguide)	7/20/2005	LA		
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